



# PMEM4020APD

PNP transistor/Schottky rectifier module

Rev. 02 — 31 August 2009

Product data sheet

## 1. Product profile

### 1.1 General description

Combination of a PNP transistor with low  $V_{CEsat}$  and high current capability and a planar Schottky barrier rectifier with an integrated guard ring for stress protection in a SOT457 (SC-74) small plastic package. NPN complement: PMEM4020AND

### 1.2 Features

- 600 mW total power dissipation
- High current capability up to 2 A
- Reduces printed-circuit board area required
- Reduces pick and place costs
- Small plastic SMD package
- Transistor
  - ◆ Low collector-emitter saturation voltage
- Diode
  - ◆ Ultra high-speed switching
  - ◆ Very low forward voltage
  - ◆ Guard ring protected

### 1.3 Applications

- DC-to-DC converters
- Inductive load drivers
- General purpose load drivers
- Reverse polarity protection circuits
- MOSFET drivers

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>PNP transistor</b>						
$V_{CEO}$	collector-emitter voltage	open base	-	-	-40	V
$I_C$	collector current (DC)	continuous; $T_s \leq 55\text{ °C}$	[1] -	-	-2	A

Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Schottky barrier rectifier</b>						
$V_R$	continuous reverse voltage		-	-	40	V
$I_F$	continuous forward current		-	-	1	A

[1] Soldering point of collector or cathode tab.

## 2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Symbol
1	emitter		<p style="text-align: right;"><i>sym040</i></p>
2	not connected		
3	cathode		
4	anode		
5	base		
6	collector		

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMEM4020APD	SC-74	plastic surface mounted package; 6 leads	SOT457

## 4. Marking

Table 4. Marking

Type number	Marking code
PMEM4020APD	D3

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
<b>PNP transistor</b>					
$V_{CBO}$	collector-base voltage	open emitter	-	-40	V
$V_{CEO}$	collector-emitter voltage	open base	-	-40	V
$V_{EBO}$	emitter-base voltage	open collector	-	-5	V

**Table 5. Limiting values ...continued**  
*In accordance with the Absolute Maximum Rating System (IEC 60134).*

Symbol	Parameter	Conditions	Min	Max	Unit
I <sub>C</sub>	collector current (DC)	continuous	[1] -	-0.75	A
		continuous	[2] -	-1	A
		continuous	[3] -	-1.3	A
		continuous; T <sub>s</sub> ≤ 55 °C	[4] -	-2	A
I <sub>CM</sub>	peak collector current		-	-3	A
I <sub>BM</sub>	peak base current		-	-1	A
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1] -	295	mW
		T <sub>amb</sub> ≤ 25 °C	[2] -	400	mW
		T <sub>amb</sub> ≤ 25 °C	[3] -	500	mW
		T <sub>s</sub> ≤ 55 °C	[4] -	1000	mW
T <sub>j</sub>	junction temperature		-	150	°C
<b>Schottky barrier rectifier</b>					
V <sub>R</sub>	continuous reverse voltage		-	40	V
I <sub>F</sub>	continuous forward current		-	1	A
I <sub>FRM</sub>	repetitive peak forward current	t <sub>p</sub> ≤ 1 ms; δ ≤ 0.5	-	3.5	A
I <sub>FSM</sub>	non-repetitive peak forward current	t = 8 ms; square wave	-	10	A
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1] -	295	mW
		T <sub>amb</sub> ≤ 25 °C	[2] -	400	mW
		T <sub>amb</sub> ≤ 25 °C	[3] -	500	mW
		T <sub>s</sub> ≤ 55 °C	[4] -	1000	mW
T <sub>j</sub>	junction temperature		[2] -	150	°C
<b>Combined device</b>					
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[2] -	600	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>amb</sub>	ambient temperature		[2] -65	+150	°C

- [1] Mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.
- [2] Device mounted on a printed-circuit board, single-sided copper, tin-plated, 1cm<sup>2</sup> mounting pad for both collector and cathode.
- [3] Mounted on a ceramic printed-circuit board, single-sided copper, tin-plated, standard footprint.
- [4] Soldering point of collector or cathode tab.

## 6. Thermal characteristics

Table 6. Thermal characteristics<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Single device</b>						
$R_{th(j-s)}$	thermal resistance from junction to soldering point	in free air	<sup>[2]</sup> -	-	95	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<sup>[3]</sup> -	-	250	K/W
			<sup>[4]</sup> -	-	315	K/W
			<sup>[5]</sup> -	-	425	K/W
<b>Combined device</b>						
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<sup>[3]</sup> -	-	208	K/W

[1] For Schottky barrier rectifiers thermal run-away has to be considered, as in some applications the reverse power losses  $P_R$  are a significant part of the total power losses. Nomograms for determining the reverse power losses  $P_R$  and  $I_{F(AV)}$  rating will be available on request.

[2] Soldering point of collector or cathode tab.

[3] Mounted on a ceramic printed-circuit board, single-sided copper, tin-plated, standard footprint.

[4] Device mounted on a printed-circuit board, single-sided copper, tin-plated, 1 cm<sup>2</sup> mounting pad for both collector and cathode tab.

[5] Mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.

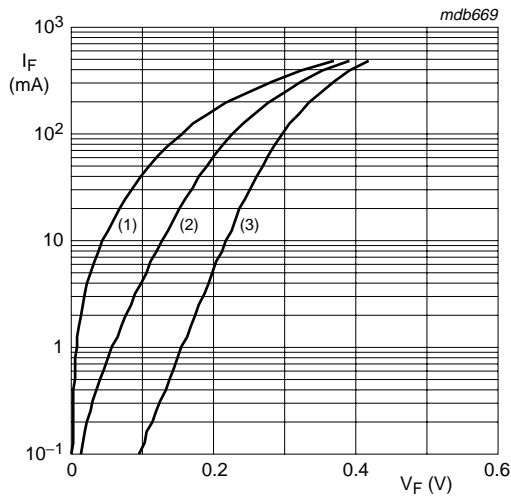
## 7. Characteristics

**Table 7. Characteristics**

$T_{amb} = 25\text{ °C}$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>PNP transistor</b>						
$I_{CBO}$	collector-base cut-off current	$V_{CB} = -40\text{ V}; I_E = 0\text{ A}$	-	-	-100	nA
		$V_{CB} = -40\text{ V}; I_E = 0\text{ A}; T_j = 150\text{ °C}$	-	-	-50	$\mu\text{A}$
$I_{CEO}$	collector-emitter cut-off current	$V_{CE} = -30\text{ V}; I_B = 0\text{ A}$	-	-	-100	nA
$I_{EBO}$	emitter-base cut-off current	$V_{EB} = -5\text{ V}; I_C = 0\text{ A}$	-	-	-100	nA
$h_{FE}$	DC current gain	$V_{CE} = -5\text{ V}; I_C = -1\text{ mA}$	300	-	-	
		$V_{CE} = -5\text{ V}; I_C = -100\text{ mA}$	300	-	-	
		$V_{CE} = -5\text{ V}; I_C = -500\text{ mA}$	250	-	900	
		$V_{CE} = -5\text{ V}; I_C = -1\text{ A}$	160	-	-	
		$V_{CE} = -5\text{ V}; I_C = -2\text{ A}$	[1] 50	-	-	
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = -100\text{ mA}; I_B = -1\text{ mA}$	-	-	-120	mV
		$I_C = -500\text{ mA}; I_B = -50\text{ mA}$	-	-	-145	mV
		$I_C = -1\text{ A}; I_B = -100\text{ mA}$	-	-	-260	mV
		$I_C = -2\text{ A}; I_B = -200\text{ mA}$	-	-	-530	mV
$R_{CEsat}$	equivalent on-resistance	$I_C = -1\text{ A}; I_B = -100\text{ mA}$	[1] -	180	280	$\text{m}\Omega$
$V_{BEsat}$	base-emitter saturation voltage	$I_C = -1\text{ A}; I_B = -100\text{ mA}$	[1] -	-	-1.1	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -5\text{ V}; I_C = -1\text{ A}$	[1] -	-	-1.0	V
$f_T$	transition frequency	$V_{CE} = -10\text{ V}; I_C = -50\text{ mA}; f = 100\text{ MHz}$	150	-	-	MHz
$C_c$	collector capacitance	$V_{CB} = -10\text{ V}; I_E = I_e = 0\text{ A}; f = 1\text{ MHz}$	-	-	10	pF
<b>Schottky barrier rectifier</b>						
$V_F$	continuous forward voltage	see <a href="#">Figure 1</a>				
		$I_F = 0.1\text{ mA}$	[1] -	95	130	mV
		$I_F = 1\text{ mA}$	[1] -	155	210	mV
		$I_F = 10\text{ mA}$	[1] -	220	270	mV
		$I_F = 100\text{ mA}$	[1] -	295	350	mV
$I_R$	reverse current	see <a href="#">Figure 2</a>				
		$V_R = 10\text{ V}$	[1] -	7	20	$\mu\text{A}$
		$V_R = 40\text{ V}$	[1] -	30	100	$\mu\text{A}$
$C_d$	diode capacitance	$V_R = 1\text{ V}; f = 1\text{ MHz};$ see <a href="#">Figure 3</a>	-	43	48	pF

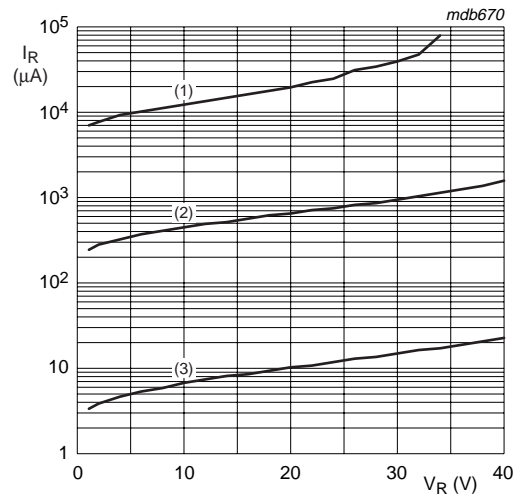
[1] Pulse test:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$



**Schottky barrier rectifier**

- (1)  $T_{amb} = 150\text{ }^{\circ}\text{C}$
- (2)  $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (3)  $T_{amb} = 25\text{ }^{\circ}\text{C}$

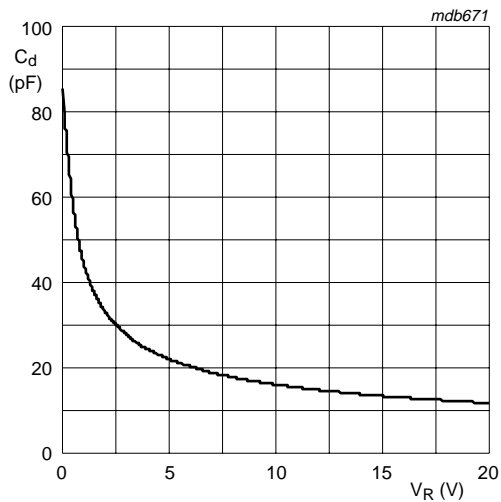
**Fig 1. Forward current as a function of forward voltage; typical values**



**Schottky barrier rectifier**

- (1)  $T_{amb} = 150\text{ }^{\circ}\text{C}$
- (2)  $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (3)  $T_{amb} = 25\text{ }^{\circ}\text{C}$

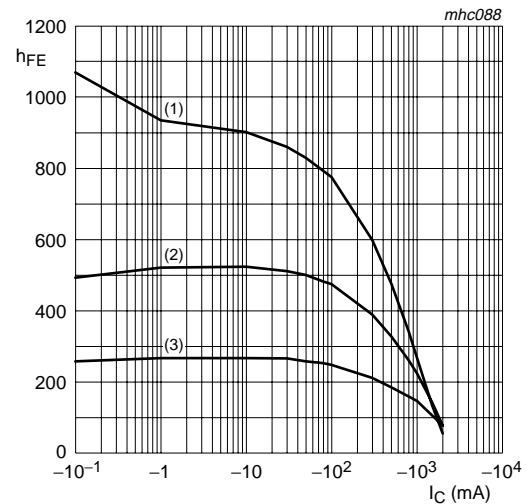
**Fig 2. Reverse current as a function of reverse voltage; typical values**



**Schottky barrier rectifier;**

$T_{amb} = 25\text{ }^{\circ}\text{C}; f = 1\text{ MHz}$

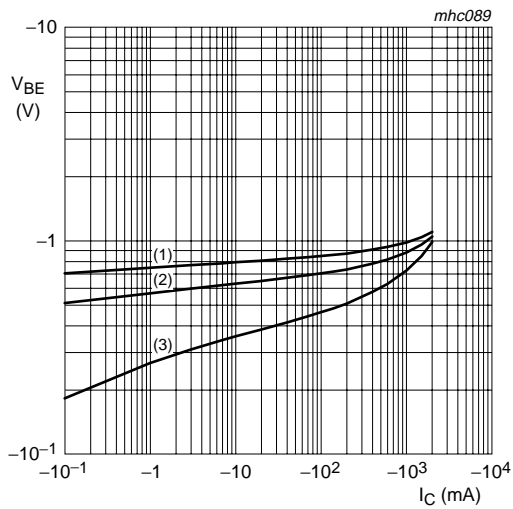
**Fig 3. Diode capacitance as a function of reverse voltage; typical values**



**PNP transistor;  $V_{CE} = -5\text{ V}$**

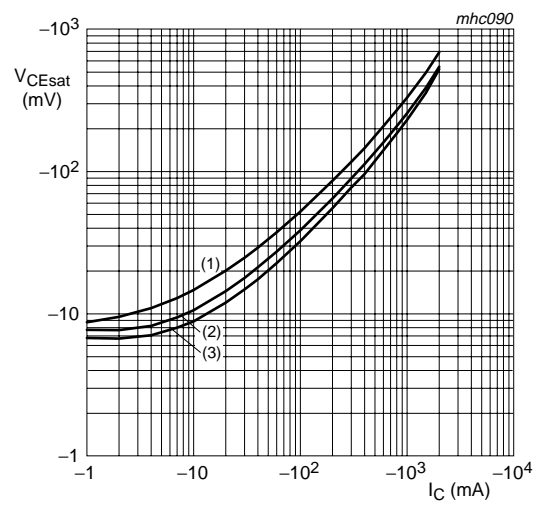
- (1)  $T_{amb} = 150\text{ }^{\circ}\text{C}$
- (2)  $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (3)  $T_{amb} = -55\text{ }^{\circ}\text{C}$

**Fig 4. DC current gain as a function of collector current; typical values**



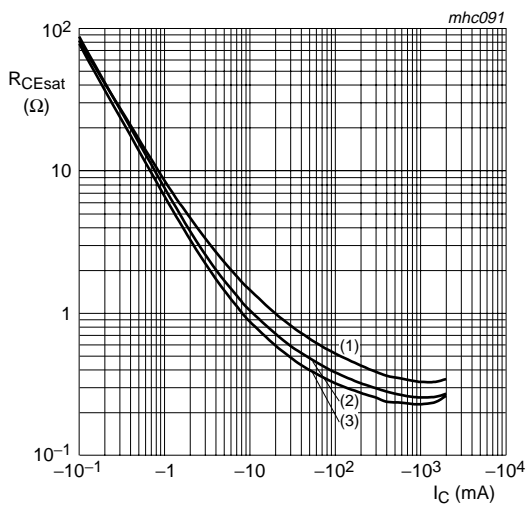
**PNP transistor;  $V_{CE} = -5\text{ V}$**   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 150\text{ °C}$

**Fig 5. Base-emitter voltage as a function of collector current; typical values**



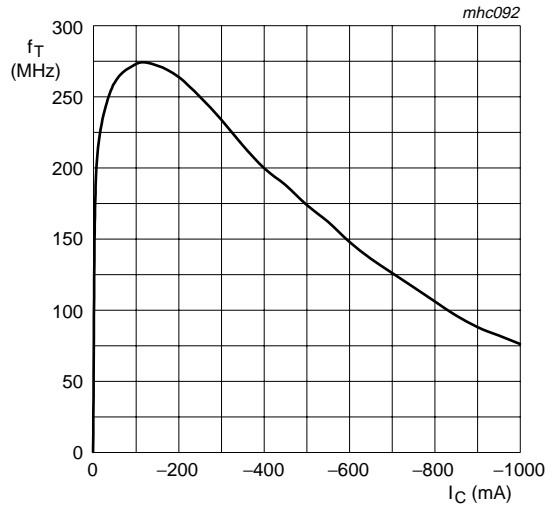
**PNP transistor;  $I_C/I_B = 10$**   
 (1)  $T_{amb} = 150\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 6. Collector-emitter saturation voltage as a function of collector current; typical values**



**PNP transistor;  $I_C/I_B = 10$**   
 (1)  $T_{amb} = 150\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

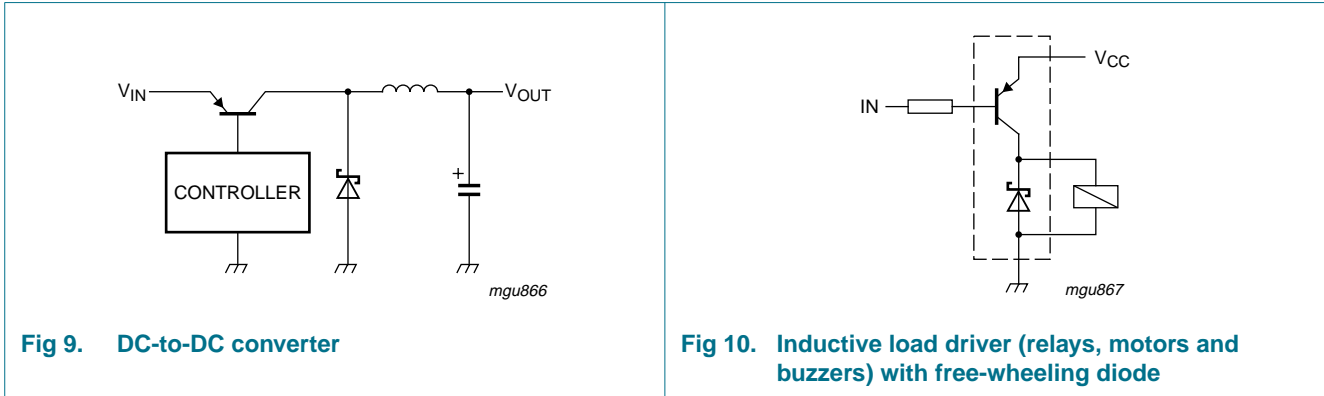
**Fig 7. Equivalent on-resistance as a function of collector current; typical values**



**PNP transistor;  $V_{CE} = -10\text{ V}$**

**Fig 8. Transition frequency as a function of collector current**

**8. Application information**





9. Package outline

Plastic surface-mounted package (TSOP6); 6 leads

SOT457

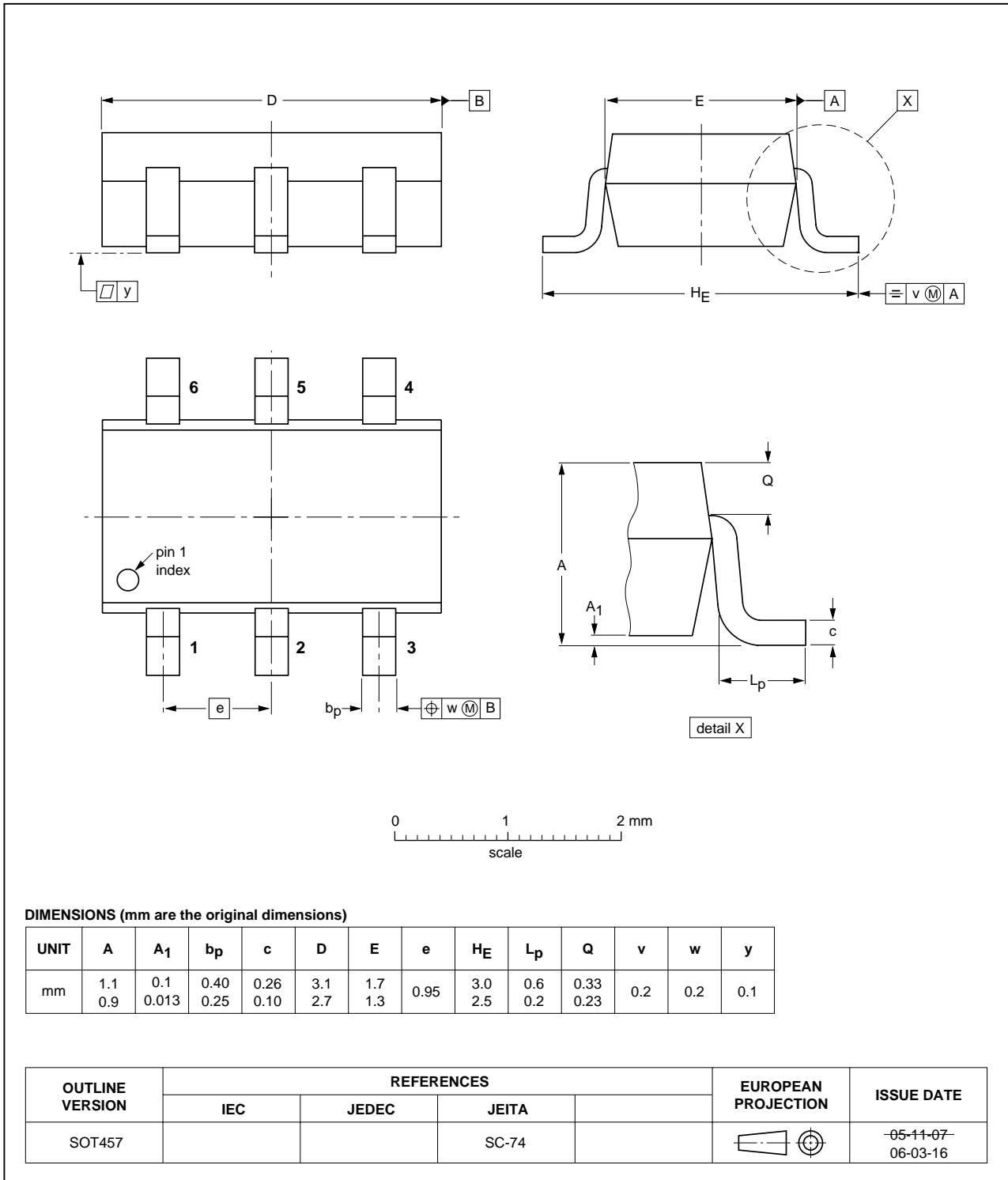


Fig 11. Package outline SOT457 (SC-74)

## 10. Packing information

**Table 8. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

Type number	Package	Description	Packing quantity	
			3000	10000
PMEM4020APD	SOT457	4 mm pitch, 8 mm tape and reel; T1	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	-125	-165

[1] For further information and the availability of packing methods, see [Section 13](#).

## 11. Revision history

**Table 9. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMEM4020APD_2	20090831	Product data sheet	-	PMEM4020APD_1
Modifications:	<ul style="list-style-type: none"> <li>• This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content.</li> <li>• <a href="#">Table 2 “Discrete pinning”</a>: amended</li> <li>• <a href="#">Figure 11 “Package outline SOT457 (SC-74)”</a>: updated</li> </ul>			
PMEM4020APD_1	20041004	Product data sheet	-	-

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### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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 Date of release: 31 August 2009  
 Document identifier: PMEM4020APD\_2